

FEATURES

- 256-channel, current-to-digital converter module**
- Up to 24-bit resolution**
- Variable integration time**
 - Fastest integration time: 11.656 kSPS (86 μ s) at 20-bit resolution
- Low power dissipation: 3 mW per channel at any throughput**
- Integral linearity**
 - $\pm 0.015\%$ of reading ± 0.4 ppm of FSR: single channel active
 - $\pm 0.050\%$ of reading ± 1.0 ppm of FSR: all channels active
- Very low noise**
- Simultaneous sampling**
 - No dead time, no loss of charge, 100% charge collection
- User adjustable full-scale range**
- On-board temperature sensor and reference buffer**
- 15 mm \times 15 mm, CSP_BGA package**
- Simple printed circuit board (PCB) design**
 - Integrated capacitors for supply and reference decoupling
 - 0.80 mm pitch BGA allows low cost PCB technology
- Support tools**
 - Evaluation board
 - Reference design with reference layout
 - FPGA Verilog code

APPLICATIONS

- Medical, industrial, and security CT scanner data acquisition**
- Photodiode sensors**

- Dosimetry and radiation therapy systems**
- Optical fiber power monitoring**
- X-ray detection systems**
- High channel-count data acquisition systems (current or voltage inputs)**

GENERAL DESCRIPTION

The **ADAS1131** is a 256-channel, current-to-digital analog-to-digital converter (ADC) module. It contains 256 low power, low noise, low input current integrators, simultaneous sample-and-holds, and two high speed, high resolution ADCs with configurable sampling rate and resolutions of up to 24 bits. The signal chain and sampling architecture of the **ADAS1131** is designed to guarantee that all channels are simultaneously sampled, and that no charge is lost throughout the sampling process.

All converted channel results are output on a single, low voltage differential signaling (LVDS), self clocked serial interface, which reduces external hardware.

An SPI-compatible serial interface allows configuration of the ADC using the SDI_x input. The SDO_x output allows the user to daisy-chain several ADCs on a single, 3-wire bus. The **ADAS1131** uses the separate supply, IOVDD, to reduce digital noise effect on the conversions.

The **ADAS1131** is in a 15 mm \times 15 mm, CSP_BGA package.

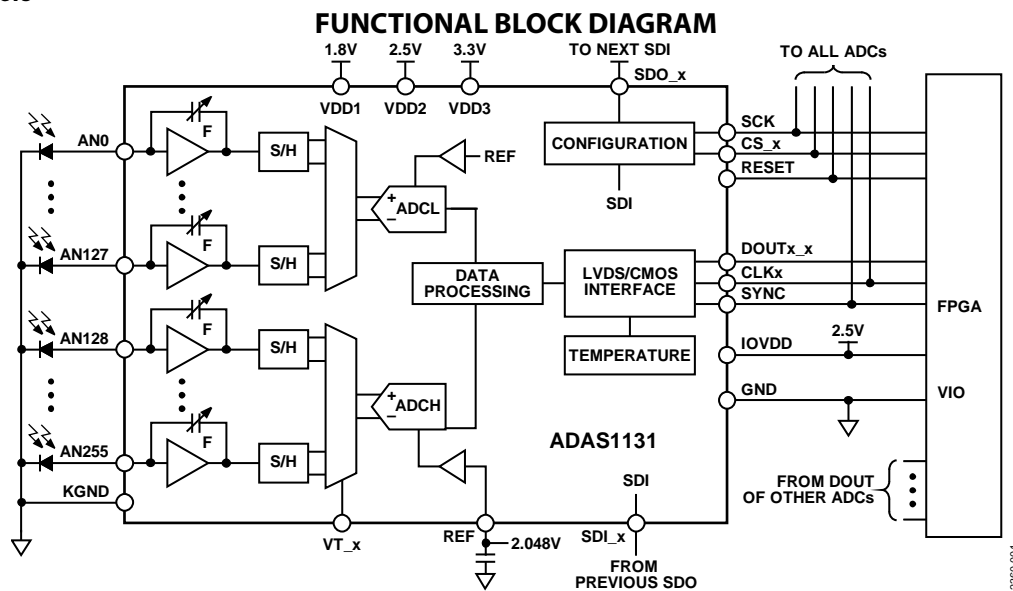


Figure 1.

For more information about the **ADAS1131**, email adas@analog.com.

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COMPARABLE PARTS

View a parametric search of comparable parts.

DOCUMENTATION

Data Sheet

- ADAS1131: 256-Channel, 24-Bit Current-to-Digital ADC Module Data Sheet

REFERENCE MATERIALS

Press

- Industry's First 256-Channel, 24-Bit Current-to-Digital Converter Module for CT Scanners Simplifies Design and Reduces System Costs

DESIGN RESOURCES

- ADAS1131 Material Declaration
- PCN-PDN Information
- Quality And Reliability
- Symbols and Footprints

DISCUSSIONS

View all ADAS1131 EngineerZone Discussions.

SAMPLE AND BUY

Visit the product page to see pricing options.

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